

Notice of References Cited	Application/Control No. 10/600,310	Applicant(s)/Patent Under Reexamination YEH ET AL.	
	Examiner Soon D. Hyun	Art Unit 2616	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,912,258	06-2005	Birru, Dagnachew	375/340
*	B	US-6,952,394	10-2005	Kim et al.	370/208
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NON-PATENT DOCUMENTS

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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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